

## SI7613DN-VB Datasheet

# P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
- 20	0.0040 at V <sub>GS</sub> = 10 V	- 52	21.5 nC			
- 20	0.0060 at V <sub>GS</sub> = 4.5 V	- 40	21.5110			

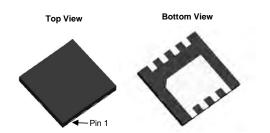
### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

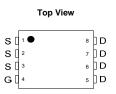


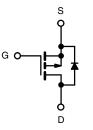
#### **APPLICATIONS**

- Load Switch
- · Adaptor/Battery Switch



DFN 3x3 EP





P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)						
Parameter		Symbol	Limit	Unit		
Drain-Source Voltage		$V_{DS}$	- 20	V		
Gate-Source Voltage		V <sub>GS</sub> ± 16				
	T <sub>C</sub> = 25 °C		- 52			
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	- 40 <sup>g</sup>			
Continuous Diam Current (1) = 150 °C)	T <sub>A</sub> = 25 °C	טי	- 26 <sup>b, c</sup>			
	T <sub>A</sub> = 70 °C		- 21 <sup>b, c</sup>	Α		
Pulsed Drain Current		I <sub>DM</sub>	- 150			
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	- 40 <sup>g</sup>			
Continuous Course Brain Blode Carrent	T <sub>A</sub> = 25 °C	.20	- 4.5 <sup>b, c</sup>			
	T <sub>C</sub> = 25 °C		54	W		
Maximum Power Dissipation	$T_C = 70  ^{\circ}C$	P <sub>D</sub>	34.7			
Waximum Tower Biosipation	T <sub>A</sub> = 25 °C	. 0	5.0 <sup>b, c</sup>	**		
	T <sub>A</sub> = 70 °C		3.2 <sup>b, c</sup>	]		
Operating Junction and Storage Temperature Ran	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C			
Soldering Recommendations (Peak Temperature)		260	9			

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	$R_{thJA}$	20	25	°C/W
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	1.8	2.3	<i>5,</i> <b>v v</b>

#### Notes

- a. Based on  $T_C$  = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				7.		<u> </u>
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = - 250 μA	- 20			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 vA		- 15		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		4.5		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 2.2	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 16 \text{ V}$			± 100	nA
7 0		V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V			- 1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α
	Б	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 26 A		0.0040		Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 21 A		0.0060		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 26 A		58		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			4595		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		910		
Reverse Transfer Capacitance	C <sub>rss</sub>			813		
Total Cata Charge	Qg	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 20 A		95.3	143	nC
Total Gate Charge				46.5	70	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$		13.7		
Gate-Drain Charge	$Q_{gd}$			12.5		
Gate Resistance	$R_g$	f = 1 MHz	0.4	1.9	3.8	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			19	30	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = - 10 V, R <sub>L</sub> = 1 Ω		10	20	1
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		65	98	
Fall Time	t <sub>f</sub>			13	20	no
Turn-On Delay Time	t <sub>d(on)</sub>			55	83	ns ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 1 $\Omega$		52	78	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		53	80	
Fall Time	t <sub>f</sub>			25	38	
<b>Drain-Source Body Diode Characteris</b>	tics					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 40	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 70	A
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 1 A		- 0.74	- 1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			42	63	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	 		25	38	nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = - 10 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		12		
Reverse Recovery Rise Time	t <sub>b</sub>			30		ns

#### Notes:

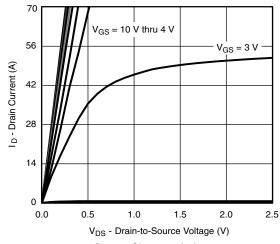
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- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

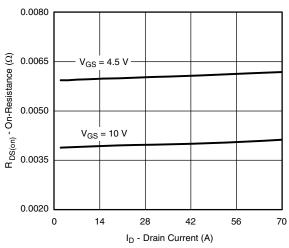
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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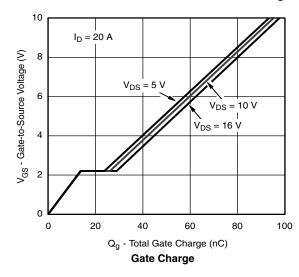


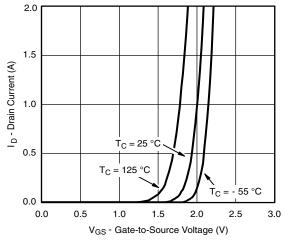




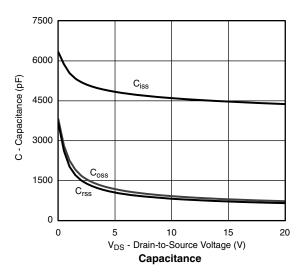


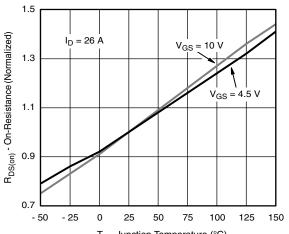
On-Resistance vs. Drain Current and Gate Voltage





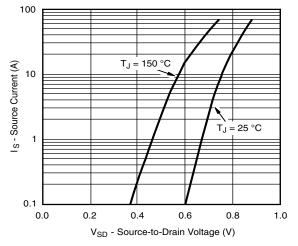
**Transfer Characteristics** 

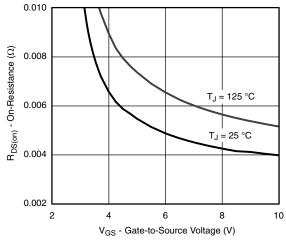




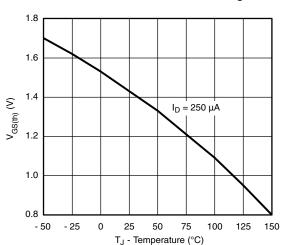
 $T_J$  - Junction Temperature (°C) **On-Resistance vs. Junction Temperature** 



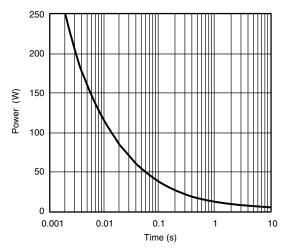




### Source-Drain Diode Forward Voltage

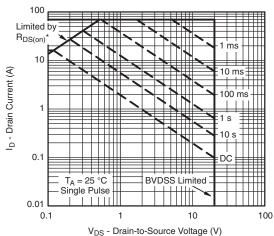


On-Resistance vs. Gate-to-Source Voltage



#### **Threshold Voltage**

Single Pulse Power, Junction-to-Ambient

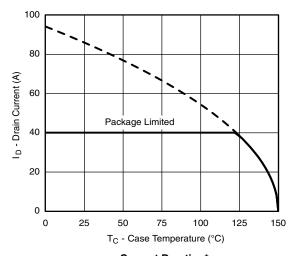


 $v_{DS}$  - Drain-to-Source voltage (v) \*  $v_{GS}$  > minimum  $v_{GS}$  at which  $v_{DS}$  is specified

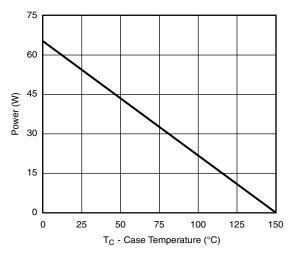
Safe Operating Area, Junction-to-Ambient

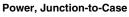
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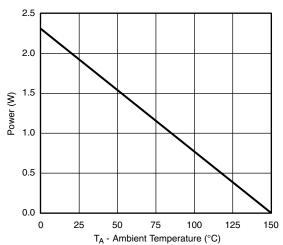




## **Current Derating\***





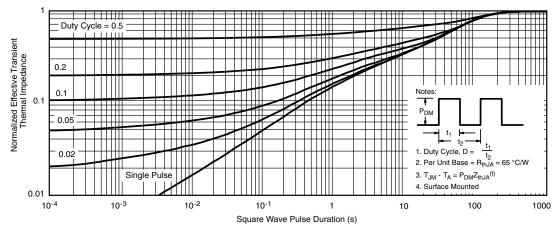


Power, Junction-to-Ambient

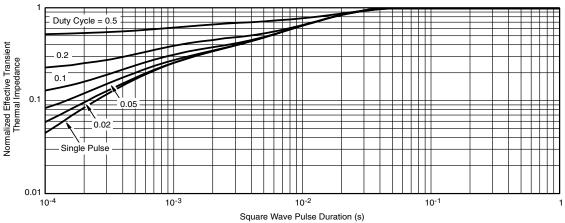
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



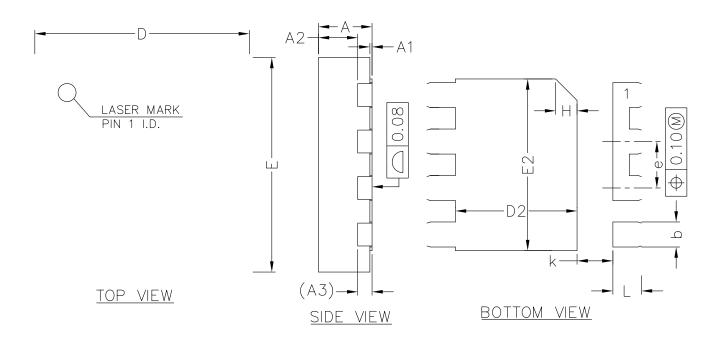


Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX	
А	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A2	0.50	0.55	0.60	
А3	0.20REF			
b	0.30	0.35	0.40	
D	2.90	3.00	3.10	
Е	2.90	3.00	3.10	
D2	1.60	1.70	1.80	
E2	2.30	2.40	2.50	
е	0.55	0.65	0.75	
K	0.40	0.50	0.60	
L	0.35	0.40	0.45	

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